

SURFACE MOUNT TAPE AND REEL



LDGM9033/TR1

DATA SHEET

DOC. NO : QW0905-LDGM9033/TR1

REV : A

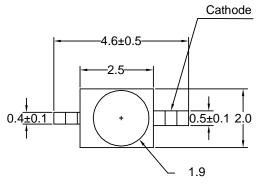
DATE : 04 - Aug - 2005

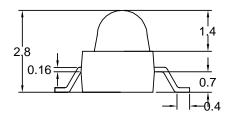


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Package Dimensions

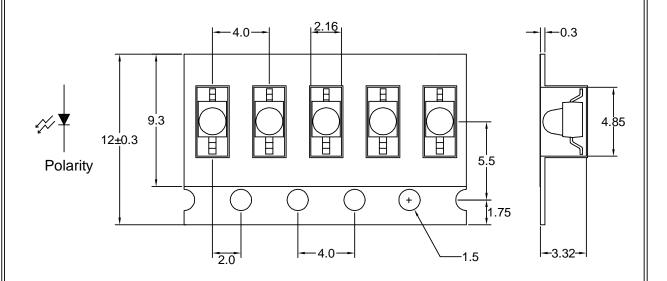




Note: 1.All dimension are in millimeter tolerance is ±0.2mm unless otherwise noted.

2. Specifications are subject to change without notice.

Carrier Type Dimensions

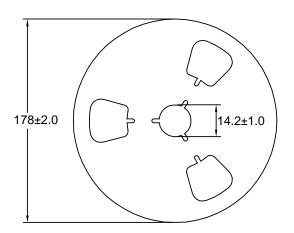


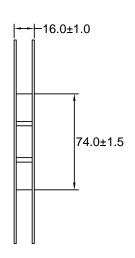
Note : The tolerances unless mentioned is ± 0.2 mm,Angle ± 0.5 . Unit=mm.



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Reel Dimensions





Part No.	Description	Quantity/Reel		
LDGM9033/TR1	12.0mm tape,7"reel	1500 devices		



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Absolute Maximum Ratings at Ta=25

Doromotor	Symbol	Ratings	UNIT	
Parameter	Symbol	DGM		
Forward Current	lF	30	mA	
Peak Forward Current Duty 1/10@10KHz	lfp	100	mA	
Power Dissipation	PD	120	mW	
Reverse Current @5V	lr	50	μΑ	
Electrostatic Discharge	ESD	150	٧	
Operating Temperature	Topr	-20 ~ +80		
Storage Temperature	Tstg	-30 ~ +100		
Soldering Temperature	Tsol	Max 260 for 5 sec Max (2mm from body)		

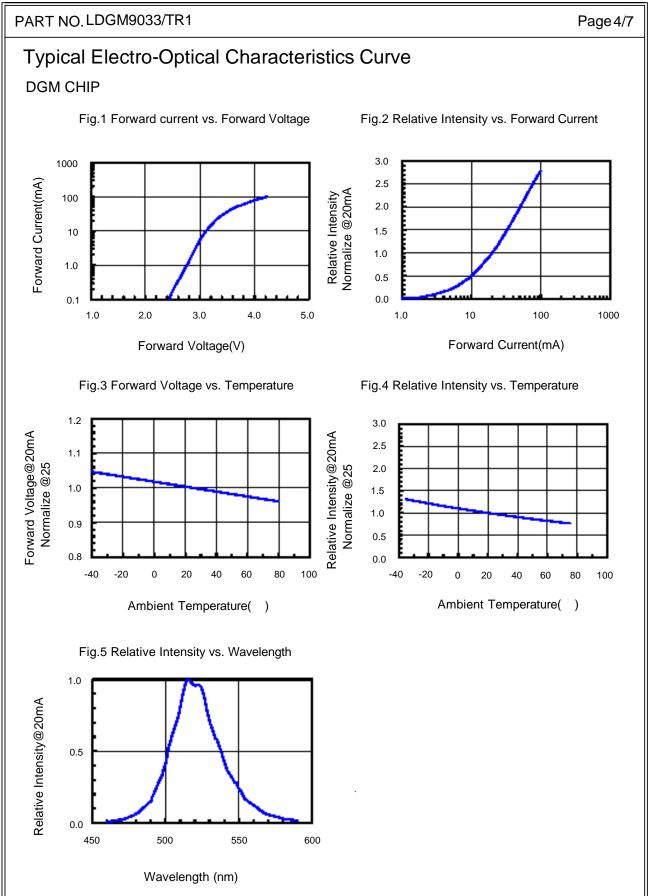
Typical Electrical & Optical Characteristics (Ta=25)

PART NO	MATERIAL		OLOR	Peak wave length Pnm	wave length	Spectral halfwidth nm	volt	vard age mA(V)	inter	nous nsity A(mcd)	Viewing angle 2 1/2 (deg)
		Emitted	Lens				Тур.	Max.	Min.	Тур.	
LDGM9033/TR1	InGaN/GaN	Green	Water Clear	518	525	36	3.5	4.0	1100	1800	20

Note: 1.The forward voltage data did not including ±0.1V testing tolerance.

2. The luminous intensity data did not including ±15% testing tolerance.







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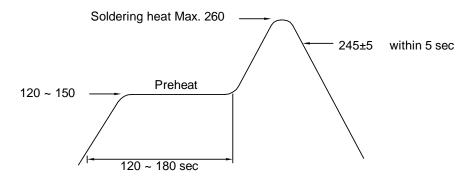
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Recommended Soldering Conditions

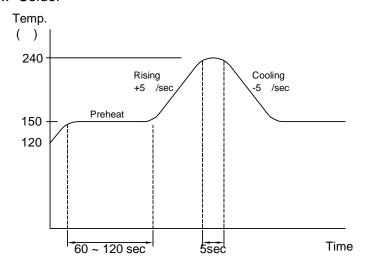
1. Hand Solder

Basic spec is 280 3 sec one time only.

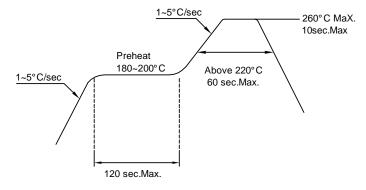
2. Wave Solder



3-1. LEAD Reflow Solder



3-2 PB-Free Reflow Solder



Reflow Soldering should not be done more than two times.



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Precautions For Use:

Storage time:

- 1. The operation of Temperatures and RH are: 5 ~35 ,RH60%.
- 2.Once the package is opened, the products should be used within a week. Otherwise, they should be kept in a damp proof box with descanting agent. Considering the tape life, we suggest our customers to use our products within a year(from production date).
- 3.If opened more than one week in an atmosphere 5 \sim 35 ,RH60%, they should be treated at 60 \pm 5 fo r 15hrs.

Drive Method:

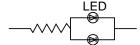
LED is a current operated device, and therefore, requirer some kind of current limiting incorporated into the driver circuit. This current limiting typically takes the form of a current limiting resistor placed in series with the LED.

Consider worst case voltage variations than could occur across the current limiting resistor. The forwrd current should not be allowed to change by more than 40 % of its desired value.

Circuit model A

Circuit model B





- (A) Recommended circuit.
- (B) The difference of brightness between LED could be found due to the VF-IF characteristics of LED.

Cleaning:

Use alcohol-based cleaning solvents such as isopropyl alcohol to clean the LED.

ESD(Electrostatic Discharge):

Static Electricity or power surge will damage the LED. Use of a conductive wrist band or anti-electrosatic glove is recommended when handing these LED. All devices, equipment and machinery must be properly grounded.



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Reliability Test:

Test Item	Test Condition	Description	Reference Standard	
Operating Life Test	1.Under Room Temperature 2.If=20mA 3.t=1000 hrs (-24hrs, +72hrs)	This test is conducted for the purpose of detemining the resisance of a part in electrical and themal stressed.	MIL-STD-750: 1026 MIL-STD-883: 1005 JIS C 7021: B-1	
High Temperature Storage Test	1.Ta=105 ±5 2.t=1000 hrs (-24hrs, +72hrs)	The purpose of this is the resistance of the device which is laid under ondition of high temperature for hours.	MIL-STD-883:1008 JIS C 7021: B-10	
Low Temperature Storage Test	1.Ta=-40 ±5 2.t=1000 hrs (-24hrs, +72hrs)	The purpose of this is the resistance of the device which is laid under condition of low temperature for hours.	JIS C 7021: B-12	
High Temperature High Humidity Test	1.Ta=65 ±5 2.RH=90 %~95 % 3.t=240hrs ±2hrs	The purpose of this test is the resistance of the device under tropical for hous.	MIL-STD-202:103B JIS C 7021: B-11	
Thermal Shock Test	1.Ta=105 ±5 &-40 ±5 (10min) (10min) 2.total 10 cycles	The purpose of this is the resistance of the device to sudden extreme changes in high and low temperature.	MIL-STD-202: 107D MIL-STD-750: 1051 MIL-STD-883: 1011	
Solder Resistance Test	1.T.Sol=260 ±5 2.Dwell time= 10 ±1sec.	This test intended to determine the thermal characteristic resistance of the device to sudden exposures at extreme changes in temperature when soldering the lead wire.	MIL-STD-202: 210A MIL-STD-750: 2031 JIS C 7021: A-1	
Solderability Test	1.T.Sol=230 ±5 2.Dwell time=5 ±1sec	This test intended to see soldering well performed or not.	MIL-STD-202: 208D MIL-STD-750: 2026 MIL-STD-883: 2003 JIS C 7021: A-2	